

MAR 07 2005

Sheet 1 of 1

Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. <b>13906-156001</b>	Application No. <b>10/814,833</b>
	Applicant <b>Yuh-Cherng Wu</b>			
	Filing Date <b>March 31, 2004</b>		Group Art Unit <b>2121</b>	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
PFC	AA	5,745,675	04/28/1998	Herbig et al.			
PFC	AB	5,754,755	05/19/1998	Smith, Jr.			
PFC	AC	5,995,916	11/30/1999	Nixon et al.			
PFC	AD	6,002,868	12/14/1999	Jenkins et al.			
PFC	AE	6,078,189	06/20/2000	Noel			
PFC	AF	6,233,701	05/15/2001	Onoue			
	AG						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
PFC	AH	02/041105	05/23/2002	WIPO				
PFC	AI	1,109,101	06/20/2001	Europe				
	AJ							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AK	

Examiner Signature  <b>/Paul F. Contino/</b>	Date Considered  <b>10/30/2006</b>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Disclosure Form (PTO-1449)

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	Applicant <b>Yuh-Cherng Wu</b>		
	Filing Date	Group Art Unit	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
PFC	AA	5,440,723	8/1995	Arnold et al.	395	181	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

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	AS	
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